



# Product data sheet

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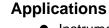


## Features

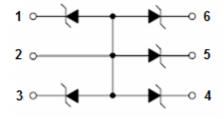
- Small SOT-363 SMT Package
- Peak Power Dissipation 100W @8 x 20 us Pulse
- Low Leakage Current < 1uA @3 Volts
- Fast Response Time < 1 ns
- Low Capacitance
- ESD Protection to IEC 61000-4-2 Level 4
- RoHS Compliant in Lead-Free Versions



**SOT363** 



- Instrumentation Equipement
- Serial and Parallel Ports
- Microprocessor Based Equipment
- Notebooks, Desktops, Servers



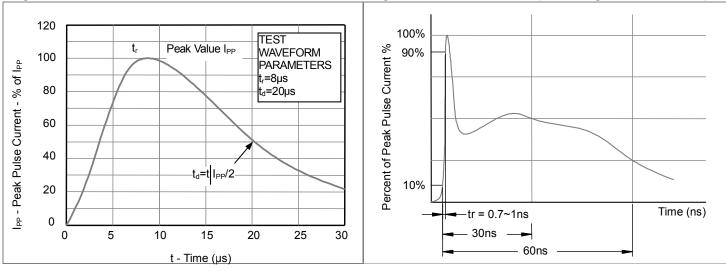
# Electrical Characteristics Ratings at 25°C ambient temperature unless otherwise specified.

P/N	Marking	V <sub>RWM</sub> (V)	Vbr (V)	l⊤ (mA)	Vc @1A	Vc		IR	С
						(Max)	(@A)	μΑ (Max)	(Pf) (Typ.)
SMF05C	5C	5	6	1	9.8	15.5	6.5	1	55

### Absolute Maximum Ratings

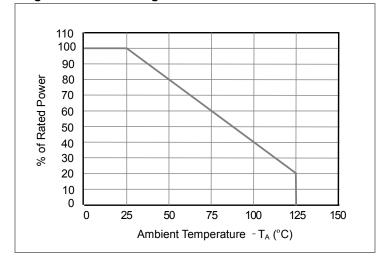
Parameter	Symbol	Value	Unit	
Peak Pulse Power (8/20µs)	Ррр	100	W	
ESD per IEC 61000-4-2 (Air)		±15	Kv	
ESD per IEC 61000-4-2 (Contact)	Vesd	±8		
Operating Temperature Range	TJ	-55 to +125	°C	
Storage Temperature Range	Тѕтј	-55 to +150	°C	





#### Fig1. 8/20µs Pulse Waveform

#### Fig3. Power Derating Curve



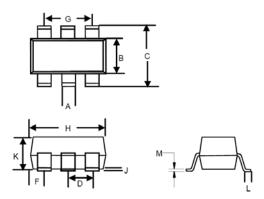
#### Fig2. ESD Pulse Waveform (according to IEC 61000-4-2)





# Package Dimensions

SOT-363



DIMENSIONS					
	INCH	ES	Μ		
DIM	MIN	MAX	MIN	MAX	NOTE
А	.004	.012	0.10	0.30	
В	.045	.053	1.15	1.35	
С	.079	.087	2.00	2.20	
D	.02	6	0.65N		
F	.012	.016	0.30	0.40	
Н	.071	.087	1.80	2.20	
J		.004		0.10	
K	.035	.039	0.90	1.00	
L	.010	.016	0.25	0.40	
М	.004	.016	0.10	0.25	

## **REEL SPECIFICATION**

P/N	PKG	QTY
SMF05C	SOT-363	3000



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